D issociation of Vortex Stacks into Fractional-Flux Vortices

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We discuss the zero eld superconducting phase transition in a nite system of magnetically coupled superconducting layers. Transverse screening is modied by the presence of other layers resulting in topological excitations with fractional ux. Vortex stacks trapping a full ux and present at any nite temperature undergo a dissociation transition which corresponds to the depairing of fractional- ux vortices in individual layers. We propose an experiment with a bi-layer system allowing to identify the dissociation of bound vortex molecules.

The zero eld superconducting to norm altransition in thin Im s and layered superconductors is triggered by the proliferation of topological defects; the unbinding of Pearl vortices [1] in thin Im s and of pancake vortices [2] in layered superconductors generates a Berezinskii-Kosterlitz-Thouless transition (BKT) [3] which has been studied in detail [4, 5]. New features emerge when going to a system with a nite number N of magnetically coupled layers. Besides Pearl type vortex stacks penetrating through the full array of layers, cf. Fig. 1 (a), fractional- ux vortices appear which reside within the individual layers [6, 7], the analogue of the pancake vortices in a layered m aterial; the reduced trapped ux associated with these vortices is due to the presence of other layers modifying transverse screening in the multi-layer system . The Pearl vortex can be viewed as a linear arrangement (stack) of fractional-

ux vortices; the intra-layer unbinding transition of these fractional- ux vortices then corresponds to the dissociation of full- ux vortex stacks present at any tem perature, cf. Fig. 1 (b). In this letter, we discuss the prospects of observing this dissociation transition in an experiment; in particular, we study a bi-layer system in a counterow geom etry which allow s to observe the dissociation of vortex m olecules into half- ux vortices, cf. Fig. 1 (c).

The basic prerequisite for the appearance of a BKT transition is the logarithm ic interaction between defects, $V(R) = 2e^2 \ln R$, where we attribute an e ective charge' e to the defects. In the absence of screening, e.g., in a super uid ⁴He lm, the logarithm ic interaction between vortices extends to in nity and the system undergoes a nite temperature BKT transition [3]. In a superconducting Im, transverse screening restricts the log-interaction to the screening length ; the Pearl vortices assume a nite self-energy V ()=2 and hence can be therm ally excited at any nite tem perature the superconducting to norm al transition then is shifted to T = 0, although a sharp crossover survives at a nite tem perature T^x_{BKT} $\hat{e}=2$ [4]. Below, we concentrate on a system with N magnetically coupled superconducting layers, i.e., vortices interact through the transverse m agnetic potential A, while the Josephson coupling due to Cooper pair tunneling between the layers is assumed to be negligible, as it is the case in a material with insu-

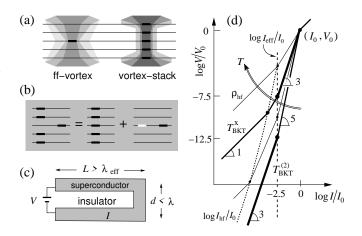


FIG.1: (a) Fractional ux vortex and vortex stack in a N = 5layer system . (b) The excursion of one vortex from the vortex stack is equivalent to the combination of a complete stack and a vortex {anti-vortex pair; pair unbinding in a layer is equivalent to stack dissociation. (c) G eom etry for the bi-layer setup shortcircuiting the e ect of vortex stacks. (d) Sketch of I-V curves at various tem peratures (see arrow); the algebraic dependence V / I with > 3 at low tem peratures turns ohm ic (= 1) at high tem peratures. The regim e between $T_{\scriptscriptstyle B\,K\,T}^{\,\,(2)}$ and $T_{\scriptscriptstyle B\,K\,T}^{\,\,X}$ contains the interesting features associated with half-ux vortices. The current scale Ie $I_0 (= e)$ (vertical dashed line) separates the physics of unscreened vortices from that of half-ux vortices. At $T_{BKT}^{(2)}$ the I-V curve exhibits the characteristic exponents 3 and 5 at sm all and large currents tracing the crossover from unscreened to halfux vortices. Above $T_{\scriptscriptstyle B\,K\,T}^{\,\,(2)}$ an additional ohm ic regim e due to free half- ux vortices appears at low currents; the dotted line m arks the crossover current I_{hf} . At tem peratures $T > T_{BKT}^{x}$ the ohm ic regim e takes over and leaves only a sm all non-linear region at high currents probing unscreened vortices.

lating layers separating the superconducting ones. The presence of additional layers leads to drastic modi cations in the potential V (R) between individual vortices in the same layer: i) the log-interaction extends to in nity, ii) the magnetic ux trapped by individual vortices is reduced to a fraction 1=N of the ux unit $_0 = hc=2e$, $_t (N) = _0=N$; the elective coupling e^2 in the interaction potential between defects is reduced correspondingly, $e^2 ! e^2 [1 = 1=N]$. Hence, the additional layers act

on the vortices in the sam e way as a dielectric m atrix acts on charged particles. The unbinding of the fractional- ux () vortices triggers a nite temperature BKT transition at $T_{BKT}^{(N)} \in 2[1 \ 1=N]=2$. At the sam e time, vortex stacks are present at any temperature; the unbinding of () vortices at $T_{BKT}^{(N)}$ then describes the dissociation of the vortex stacks rather than the superconductor-norm altransition which, strictly speaking, appears already at $T=0.\ Finally$, in a bulk layered superconductor, the magnetic

eld escapes in the transverse direction and the $\,ux$ trapped by pancake vortices saturates at $_t$ = d $_0$ =2 , where d and $\,$ denote the layer separation and the bulk planar penetration depth. The pancake-vortex unbinding at $T_{\rm BKT}^{(1)}$ e^2 =2 describes a generic phase transition as no competing stacks show up in the bulk.

Below, we address the prospect of observing fractionalux vortices in an experiment. The presence of vortices and their unpairing reveals itself in the currentvoltage characteristic. Fractional- ux vortices appear m ost prominently in a bi-layer system, see Fig. 1 (c). We propose a counter ow experiment where the contribution of stacks (vortex molecules) is eliminated. The currentinduced unpairing of vortices then produces an algebraic characteristic V / I ; the change in the exponent from = 3 to 5 with increasing current, cf. Fig. 1 (d), is a manifestation of the stack dissociation transition at $T_{BKT}^{(2)}$. In the following, we brie y derive the structure of topological excitations in layered system s, discuss their therm odynam ics, and analyze the features in the I-V characteristic related to fractional- ux vortices.

Consider a superconductor of thickness d and with a London penetration depth . Central to our discussion is the interaction potential V (R) between vortices: The current associated with a vortex is driven by the 2 -phase twist $r' = \hat{n}_z \quad R = R^2$, $j(R) = (c=4^{-2})[r'_{-0}=2 + A (R)]$; transverse screening through the vector potential A reduces the action of r' until com plete com pensation is reached once a full ux quantum $_0$ is trapped. A second vortex placed a distance R away is subject to the Lorentz force F (R) = $j(R)d_{-}=c = (2"_0d=R)[1$

(R)= $_0$], where (R) = 2 RA (R) is the ux accumulated within the distance R and " $_0$ = ($_0$ =4)² is the line energy; integrating this force provides us with the desired potential between the vortices. The incom – plete asymptotic screening with a reduced trapped ux t (R! 1) < $_0$ then gives rise to a logarithm ic interaction V (R) 2"bd[l t= $_0$]ln(R) and hence a BKT phase transition (note that e² \$ " $_0$ d).

In order to nd the ux t we have to solve the M axwell equations for the potential A. We consider a stack of N superconducting layers of thickness d_s and separated by a distance d. The penetration depth s of the layer material de nest the bulk planar penetration depth $^2 = ^2_s d=d_s$. We place the vortex at the origin of the layer positioned at z = 0 and describe the protecting layers of thickness $d^c = (N n)d$ and d = (n 1)d

above and below the lm in a continuum approximation. The system

$$r^{2}A = \frac{1}{2}A = \frac{d}{2}A + \frac{0}{2}r'$$
 (z); $d < z < d^{2}$;
 $r^{2}A = 0$; $z < d$ and $z > d^{2}$ (1)

then assumes the solution

A
$$(R;z) = \frac{-0}{2} d^{2} \int_{0}^{2} \frac{dK}{2} \frac{J_{1}(KR)}{C(K)} f(K;z);$$
 (2)

with J_1 the Bessel function and the function $f(K\;;z)=[1 \quad d^0(K\;)]e^{K_+;z;j}+ \quad d^0(K\;)e^{K_+;z;j}$ describing the z-dependence within the superconductor. Here, $d^0(K\;)=\int_{K}^{K}\frac{K}{2}+\frac{K}{2}=[(K_++K\;)e^{2K_+d^0}+(K_+-K\;)],$ with $K_+=P^{K-2+2}$ and $d^0=d^{<}(d^0=d^{>})$ in the region d< z<0 (0 < z < d^). The denominator C (K) assumes the form C (K) = [1 2 d^{<}(K\;)]K_++[1 2 d^{>}(K\;)]K_++d=^2. Outside the superconductor, the eld is obtained by replacing z > 0 (z < 0) by d^{>}(-d) in f and an additional correction factor exp [K (d^{>}-z)] (exp [K (d^{+}+z)]). The Pearl- and pancake vortices are recovered in the limits d^{<}; d^{>}=0 and d^{<}; d^{>}=1.

The magnetic ux t trapped by a vortex is extracted from the vector potential at z = 0; for a thin N -layer system with N d we nd the asymptotic form

A (R
$$_{e}$$
; z = 0) ($_{t}$ =2 R)(1 $_{e}$ =R) (3)

with parameters $_{e}$ 2²=dN and $_{t}(N)$ $_{0}=N$ independent of the layer position n. For large N the trapped ux saturates at the value $_{t} = d_{0}=2$ and $_{e} = 0$ [8], while $_{t} = _{0}$ and $_{e} = = 22 \frac{2}{s}=d_{s}$ for the thin lm. The decrease $_{t} = _{0}=N$ in trapped ux with increasing number of layers is easily understood: with N d , the same magnetic eld (and hence the same ux) is penetrating the N layers. On the other hand, a vortex stack (i.e., N () vortices) carries a full ux $_{0}$. The ux associated with one individual () vortex then is a fraction 1=N of the value trapped by the vortex stack and thus $_{t} = _{0}=N$.

The incomplete screening of the vortex singularity produces a log-interaction between vortices, V (R) = $2"_0 d \ln (R =)$ at small distances R $_e$ and V (R) = $2"_0 d [\ln (_e =) + [l _t = _0] \ln (R = _e)]$ involving a large self-energy but a reduced prefactor at large distances R $_e$. This logarithm ic interaction completes with the entropy of vortex-pair excitations and triggers a B erezinskii-K osterlitz-T houless transition at [7, 11]

$$\Gamma_{BKT}^{(N)} = \frac{n_0 d}{2} 1 - \frac{t(N)}{0} ; \qquad (4)$$

In a thin lm, t = 0 and the nite range of the interaction between Pearl vortices pushes the real transition to T = 0, in agreement with (4); the presence of one additional protecting' layer changes the situation: transverse screening reduces the trapped ux to half its value, $_{\rm t}$ = $_0$ =2, thus extending the range of the logarithm ic interaction to in nity and pushing the transition temperature to a nite value $T_{\rm BKT}^{(2)}$ = ${}^{\rm H}_0d$ =4. Adding more (N 1) layers, the trapped ux $_{\rm t}$ = $_0$ =N decreases further until assuming the asymptotic value $_{\rm t}$ = d $_0$ =2 in a bulk superconductor where $T_{\rm BKT}^{(1)}$ = ${}^{\rm H}_0d$ =2 is largest.

The appearance of a nite tem perature phase transition due to the protecting action of additional superconducting layers has its counterpart in multigap superconductors [12], cf. also R ef. 13. In both cases, the creation of a topological defect in one superconducting com ponent or layer induces screening currents in the other com ponents/layers via coupling to the common gauge eld A; the resulting incomplete screening extends the interaction between defects to in nity, although with a reduced 'charge'. A nite Josephson coupling between the layers or between the components of a multigap superconductor spoils this phenom enon through the appearance of a linear con ning potential. W hile this coupling can be (m ade) arbitrarily sm all in a layered system, the internal Josephson e ect in a multi-component superconductor cannot be tuned and is not necessarily sm all [14].

The setup where fractional- ux vortices make their most prominent appearance is the bi-layer system . Its therm odynamic properties are obtained from an extension of the renorm alization group analysis in a lm [9, 10] and involves the ow of the super uid density K (R) at scale R with K () $K_0 = "_0 d = T$ and the vortex fugacity y(R), with $(y=R)^2$ the density of vortex {anti-vortex pairs of size R. Here, the renorm alization involves a two-stage process: i) unscreened vortex pairs are integrated out on scales R < $_{\rm e}$ and provide renorm alized values (K; y) at R = e; ii) the ow is restarted with a reduced coupling " $_0d=2$ and half- ux (hf) vortex pairs are integrated out on scales R > $_{\rm e}$. We obtain the following results (see [15] for details): At tem peratures T < $T_{BKT}^{(2)} = \mathbf{u}_0 d=4$ the initial fugacity $y_0 = \exp(E_c=T)$ due to the core energy E_c "0d ows to zero and the super uid density K > 4=remains nite. Above $T_{\scriptscriptstyle\!B\,K\,T}^{\scriptscriptstyle(2)}$ (hf) vortices start unbinding: a narrow critical regime (with a correlation length $e \exp(=2^{1} \overline{b t})$, t (T $T_{BKT}^{(2)}$)= $T_{BKT}^{(2)}$ and b hf a dim ensionless parameter) is followed by a mean-eld behavior where the fugacity diverges to in nity and the renorm alized super uid density vanishes beyond the correlation length hf, de ning a density of free (hf) vortices

$$n_{\rm hf} \quad \frac{1}{2} \quad \frac{Y_0^{2=\ K}}{e} \quad \frac{2\ K}{4-\ K} = \frac{2}{4} \quad \frac{p}{Y_0} \quad \frac{a}{t}; \quad (5)$$

with a of order unity. On approaching $T_{BKT}^{x} = \mathbf{W}_{0} d=2$ the correlation length becomes comparable to $_{e}$; beyond T_{BKT}^{x} unscreened vortices start unbinding at small scales below $_{e}$. Note that vortex stacks do preem pt the super-conducting transition of the bi-layer system but preserve superconductivity within the individual layers; indeed,

the force of a (hf) vortex acting on a vortex stack vanishes rapidly beyond the elective screening length $_{\rm e}$ due to the complete screening of vortex stacks.

The presence of (hf) vortices can be traced in an experiment measuring the I-V characteristic (we denote the sheet-current density by I = jd). In the counterow geometry of Fig. 1 (c), the applied dc current acts oppositely on the two (hf) vortices constituting a stack and the linear response due to drag motion is quenched. The current-induced dissociation of pairs and stacks of (hf) vortices produces a non-linear I-V characteristic; the change in slope from 3 at low currents to 5 at high currents signals the therm odynam ic dissociation of stacks at $T_{BKT}^{(2)}$. The current-induced unbinding of (hf) vortex pairs involves a therm al activation over the bar $rier U (I) = max_R [V (R)]$ I ₀R=c] 2%dln(R_T=) at sm all distances R I _e ,while U $2\frac{1}{6}d\ln(e =) +$ $\mathbf{u}_0 d \ln (\mathbf{R}_{\mathrm{I}} = \mathbf{e}) \text{ for } \mathbf{R}_{\mathrm{I}}$ $_{\rm e}$. Here, R $_{
m I}$ h=I de− notes the unbinding scale and $I_0 = 2 \frac{R_0}{0} dc = 0$ is close to the depairing current. Applied currents sm aller than $I_e = I_0 = e_e$ probe lengths larger than e_e and the e ects of half- ux vortices becom e accessible.

The equilibrium density n_v of free vortices derives from the steady state solution of the rate equation [16] $\varrho_t n_v = {}^2n_v^2 = {}_{\rm rec}$, with / exp(U=T) the production rate of free vortices and ${}^2 = {}_{\rm rec}$ the recombination parameter. Vortex drag then produces a nite non-linear resistivity, 2 ${}_n n_v$ with ${}_n$ the normal state resistivity, and a corresponding algebraic I-V characteristic $V = V_0$ (I=L) ${}^{(I)}$ with

$$(T;I) = 1 + K (T)[1 t(R_I) = 0]$$
: (6)

The exponent depends explicitly on the ux associated with the vortices: at short scales, unscreened vortices are probed and $= 1 + K \cdot On$ the other hand, large distances probe half- ux vortices and the exponent is reduced to = 1 + K = 2. The crossover between these two regimes appears at the current L I₀. This reduction in at Ie is the most prominent feature in the I-V characteristic signalling the presence of half- ux vortices in the system; at $T_{BKT}^{(2)}$, the change in slope is from 5 at large currents to 3 at low currents, cf. Fig. 1(d). The associated voltage signals are weak as the density of $1 = \frac{2}{e}$ at T_{BKT}^{X} and free vortices is already sm all, n_v $^2=~^4_{e}~$ at the true transition point $T_{\scriptscriptstyle B\,K\,T}^{~(2)}$. nv

The temperature $T_{\text{BKT}}^{(2)}$ de nes a resistive transition due to the proliferation of free half- ux vortices. Above $T_{\text{BKT}}^{(2)}$ the ohm ic resistance appearing at low currents $I < I_{\rm hf} = I_0 = _{\rm hf}$ (probing distances larger than the correlation length $_{\rm hf}$) is determ ined by the density of free (hf) vortices, _____ ^2n_{\rm hf}. In the mean- eld regime above $T_{\text{BKT}}^{(2)}$ we can make use of (5) and _nd the location of the crossover at $I_{\rm hf}$ = I_0 ($p = (1 \ product T_{\rm product}) = e^{-1} (1 \ product T_{\rm product}) = e$

The m easurem ent of I_{hf} or $_{hf}$ in this regime provides direct access to the correlation length $_{hf}$ and its mean-eld like tem perature dependence.

In order to analyze the BKT transition at $T^{(2)}_{BKT}$ various experim ental constraints have to be accounted for: i) The system must be larger than the screening length e beyond which (hf) vortices appear. The relation (4) implies that $_{e}$ ($T_{BKT}^{(2)}$) 0:5 cm = ($T_{BKT}^{(2)}$ in K), hence 1 mm in a typical low T_c material, ii) Both ۹ the interlayer distance d and the layer thickness d_s have to be small compared to the bulk penetration depth $\,$. iii) The Josephson coupling has to be small enough to push the con nement length $_{c} = (j_{0}=j_{J})$ d beyond $_{\rm e}$; separating the superconducting layers with an insulator [17] the Josephson current j_J can be made arbitrarily small. iv) The mean-eld temperature dependence / $(1 T^2 = T_c^2)^{1=2}$ of the parameters and tends to push the tem peratures $T_{\scriptscriptstyle B\,K\,T}^{\,(2)}$ and $T_{\scriptscriptstyle B\,K\,T}^{\,\,X}$ towards the m ean- eld critical tem perature T_{c} , ($T_{_{\rm B\,K\,T}}^{\,\,{\rm x}}$ $T_{_{\rm B\,K\,T}}^{(2)}$)=T_c $4G i^{2D}$ with $G i^{(2D)} = T_c = 2"_0 (T = T_c)$ T_{RKT}^{X})= T_{C} (T_c 1 the two-dimensional G inzburg number [18]. A 0)d large G inzburg number helps in distinguishing between the tem peratures where (hf) and unscreened vortices unbind. v) The features in the I-V characteristic identifying the presence of (hf) vortices involve vortex densities which are suppressed by the sm all parameter = e. Correcting parameters for the intrinsic dirtiness of thin lm s (see [19], we assume a mean free path 1 lim ited by the layer thickness d_s) we obtain the estim ates

$$[= {}_{e} {}_{I_{BKT}^{(2)}} 1.5 10^{4} T_{c}^{1=2} d_{s}^{3=2} = {}_{c0};$$
(7)

G
$$i^{(2D)}$$
 3.2 10° T_c $^{2}_{c0 c0} = d_{s}^{2}$; (8)

where all lengths are measured in A and temperatures in Kelvin. The results (7) and (8) tell us that given the (clean-) material parameters $_{c0}$ and $_{c0}$ it is not possible to maximize both $Gi^{(2D)}$ and = e simultaneously byvarying the thickness d_s. A reasonable comprom ise can be achieved if we choose a material with _{c0} 10 K, and a thickness d 1000 A, T_c 500 A; this 10 $^{2:5}$ and Gi $^{\scriptscriptstyle (2D)}$ 10 4 . The small yields = $_{e}$ value of = _ implies a sm all vortex density and requires a high voltage resolution, while the sm allness of G $i^{(2D)}$ requires a tem perature resolution in the mK range. The characteristic halving in 1 signalling the presence of (hf) vortices below I_e involves voltages with log (V=V_0) between 7:5 and 12:5. With V _nj₀L 10 m V 100 cm , j $(T_{BKT}^{(2)})$ $10^{2} \text{ A} = \text{cm}^{2}$, (we assume n 1 cm) we nd that an experimental voltage and L resolution in the sub-pico-Volt regin e [20] allows to trace this halving in 1 over a substantial tem perature range below $T_{\scriptscriptstyle B\,K\,T}^{\,\,x}$, although the observation of this crossover at $T_{RKT}^{(2)}$ itself pushes the lim its of present days experimental capabilities. A lternatively, one can trace the presence of (hf) vortices by m easuring the characteristic m ean-eld type resistivity $_{hf}(T)$ below $T_{_{BKT}}^{x}$ and through direct

observation with a scanning SQUID m icroscope [21].

An interesting analogy appears when comparing the present system with the bi-layer quantum Hall setup at total lling = 1. The latter is expected to undergo a BKT transition into an interlayer phase coherent state, even in the absence of any tunneling between the layers [22]. The (hf) vortices discussed above (existing in one of two layers and with vorticity) correspond to topologicalexcitations (m erons) with charge e=2 and vorticity [23]; bound neutralm eron pairs have their analogue in intralayer vortex {anti-vortex pairs, while bound charged m erons correspond to vortex stacks. The unbinding of m eron-pairs in the BKT transition destroys the interlayer phase coherence and can be traced in the same type of counter ow experiment [24] as discussed above.

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